Issue Classification



Application/Control No.	Applicant(s)/Patent Under Reexamination							
10/064 410	LIN. TZUENG-YAU							

Examiner Art Unit

Choi, Michael P 2621

ORIGINAL					INTERNATIONAL CLASSIFICATION										
CLASS SUBCLASS 386 95						CLAIMED							N	ION-CL	AIMED
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CROSS REFERENCE(S)			н	0	4	N	5 / 928 (2006.01.0	1)							
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Choi, Michael P 8/20/07 (Assistant Examiner) (Date)				RAN	ETA	380 MINI	P.		Total Claims Allowed:						
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